

74F537

1-of-10 Decoder with 3-STATE Outputs

General Description

The 74F537 is one-of-ten decoder/demultiplexer with four active HIGH BCD inputs and ten mutually exclusive outputs. A polarity control input determines whether the outputs are active LOW or active HIGH. The 74F537 has 3-STATE outputs, and a HIGH signal on the Output Enable ($\overline{OE}$) input forces all outputs to the high impedance state.

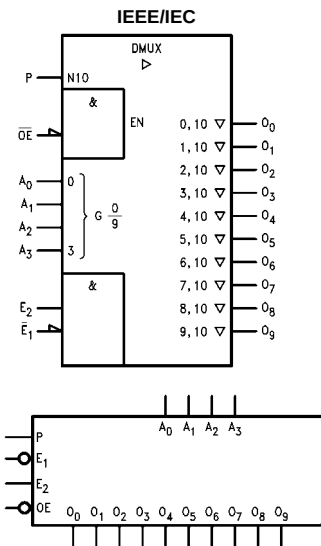
Two input enables, active HIGH E_2 and active LOW $\overline{E}_1$, are available for demultiplexing data to the selected output in either non-inverted or inverted form. Input codes greater than BCD nine cause all outputs to go to the inactive state (i.e., same polarity as the P input).

Ordering Code:

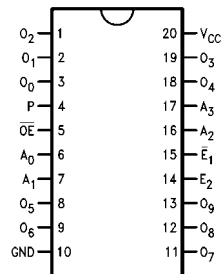
Order Number	Package Number	Package Description
74F537SC	M20B	20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
74F537PC	N20A	20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Logic Symbols



Connection Diagram



Unit Loading/Fan Out

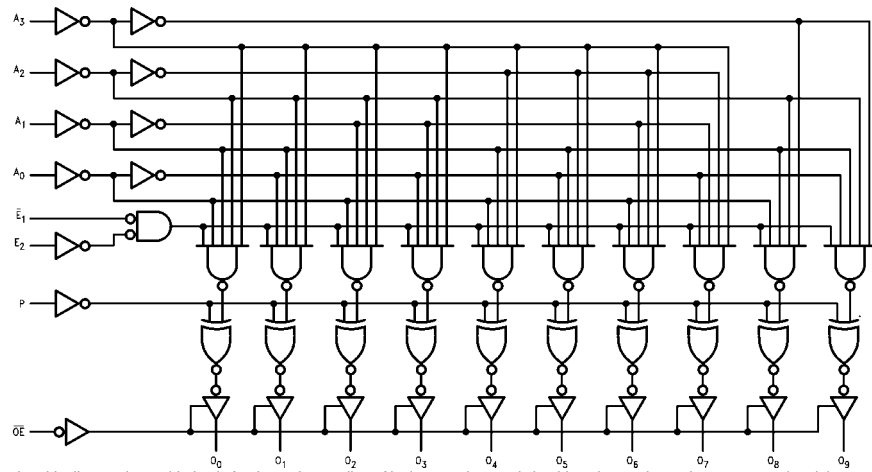
Pin Names	Description	U.L. HIGH/LOW	Input I_{IH}/I_{IL} Output I_{OH}/I_{OL}
A_0-A_3	Address Inputs	1.0/1.0	20 μA /–0.6 mA
$\overline{E}_1$	Enable Input (Active LOW)	1.0/1.0	20 μA /–0.6 mA
E_2	Enable Input (Active HIGH)	1.0/1.0	20 μA /–0.6 mA
$\overline{OE}$	Output Enable Input (Active LOW)	1.0/1.0	20 μA /–0.6 mA
P	Polarity Control Input	1.0/1.0	20 μA /–0.6 mA
O_0-O_9	3-STATE Outputs	150/40 (33.3)	–3 mA/24 mA (20 mA)

Truth Table

Function	Inputs									Outputs								
	OE	E ₁	E ₂	A ₃	A ₂	A ₁	A ₀	O ₀	O ₁	O ₂	O ₃	O ₄	O ₅	O ₆	O ₇	O ₈	O ₉	
High Impedance	H	X	X	X	X	X	X	Z	Z	Z	Z	Z	Z	Z	Z	Z	Z	
Disable	L	H	X	X	X	X	X			Outputs Equal P Input								
Active HIGH Output (P = L)	L	L	H	L	L	L	L	H	L	L	L	L	L	L	L	L	L	
	L	L	H	L	L	L	H	L	H	L	L	L	L	L	L	L	L	
	L	L	H	L	L	H	L	L	L	H	L	L	L	L	L	L	L	
	L	L	H	L	L	H	H	L	L	L	H	L	L	L	L	L	L	
	L	L	H	L	H	L	L	L	L	L	L	H	L	L	L	L	L	
	L	L	H	L	H	H	H	L	L	L	L	L	L	L	H	L	L	
	L	L	H	H	L	L	H	L	L	L	L	L	L	L	L	L	L	
	L	L	H	H	X	H	X	L	L	L	L	L	L	L	L	L	L	
	L	L	H	H	H	X	X	L	L	L	L	L	L	L	L	L	L	
	L	L	H	L	L	L	L	H	H	H	H	H	H	H	H	H	H	
	L	L	H	L	L	H	L	H	H	L	H	H	H	H	H	H	H	
	L	L	H	L	L	H	H	H	H	L	H	H	H	H	H	H	H	
	L	L	H	H	X	H	X	H	H	H	H	H	H	H	H	H	H	
L	L	H	H	H	X	X	H	H	H	H	H	H	H	H	H	H		

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial
Z = High Impedance

Logic Diagram



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

Absolute Maximum Ratings(Note 1)

Storage Temperature	−65°C to +150°C
Ambient Temperature under Bias	−55°C to +125°C
Junction Temperature under Bias	−55°C to +150°C
V _{CC} Pin Potential to Ground Pin	−0.5V to +7.0V
Input Voltage (Note 2)	−0.5V to +7.0V
Input Current (Note 2)	−30 mA to +5.0 mA
Voltage Applied to Output in HIGH State (with V _{CC} = 0V)	
Standard Output	−0.5V to V _{CC}
3-STATE Output	−0.5V to +5.5V
Current Applied to Output in LOW State (Max)	twice the rated I _{OL} (mA)

Recommended Operating Conditions

Free Air Ambient Temperature	0°C to +70°C
Supply Voltage	+4.5V to +5.5V

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

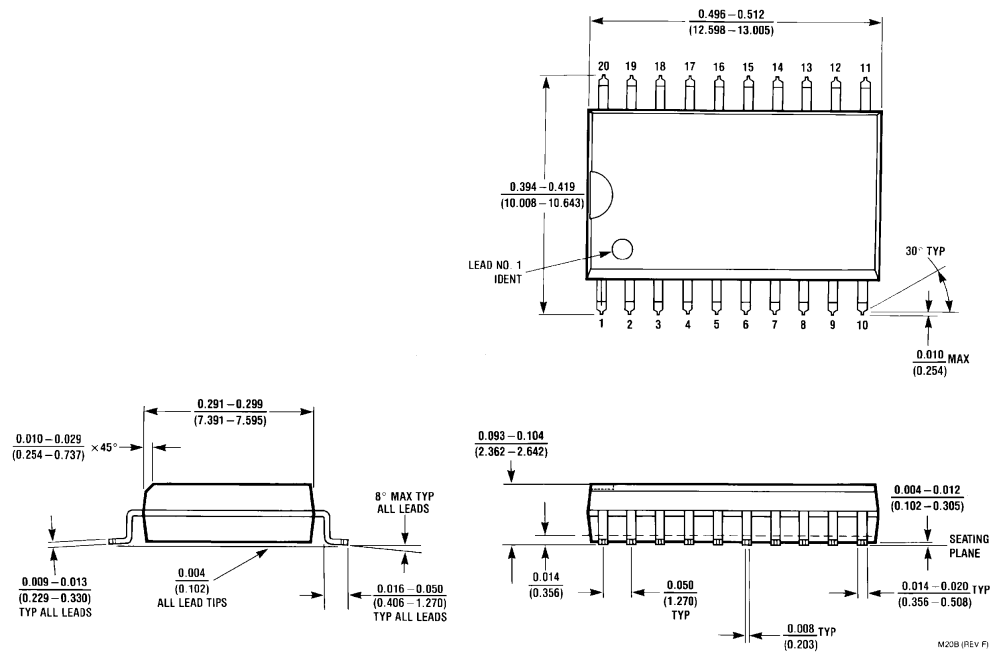
DC Electrical Characteristics

Symbol	Parameter	Min	Typ	Max	Units	V _{CC}	Conditions
V _{IH}	Input HIGH Voltage	2.0			V		Recognized as a HIGH Signal
V _{IL}	Input LOW Voltage			0.8	V		Recognized as a LOW Signal
V _{CD}	Input Clamp Diode Voltage			−1.2	V	Min	I _{IN} = −18 mA
V _{OH}	Output HIGH 10% V _{CC}	2.5			V	Min	I _{OH} = −1 mA
	10% V _{CC} Voltage	2.4					I _{OH} = −3 mA
	5% V _{CC}	2.7					I _{OH} = −1 mA
	5% V _{CC}	2.7					I _{OH} = −3 mA
V _{OL}	Output LOW Voltage 10% V _{CC}			0.5	V	Min	I _{OL} = 24 mA
I _{IH}	Input HIGH Current			5.0	μA	Max	V _{IN} = 2.7V
I _{BVI}	Input HIGH Current Breakdown Test			7.0	μA	Max	V _{IN} = 7.0V
I _{CEX}	Output HIGH Leakage Current			50	μA	Max	V _{OUT} = V _{CC}
V _{ID}	Input Leakage Test	4.75			V	0.0	I _{ID} = 1.9 μA All Other Pins Grounded
I _{OD}	Output Leakage Circuit Current			3.75	μA	0.0	V _{IOD} = 150 mV All Other Pins Grounded
I _{IL}	Input LOW Current			−0.6	mA	Max	V _{IN} = 0.5V
I _{OZH}	Output Leakage Current			50	μA	Max	V _{OUT} = 2.7V
I _{OZL}	Output Leakage Current			−50	μA	Max	V _{OUT} = 0.5V
I _{OS}	Output Short-Circuit Current	−60		−150	mA	Max	V _{OUT} = 0V
I _{ZZ}	Bus Drainage Test			500	μA	0.0V	V _{OUT} = 5.25V
I _{CCH}	Power Supply Current			56	mA	Max	V _O = HIGH
I _{CCZ}	Power Supply Current		44	66	mA	Max	V _O = HIGH Z

AC Electrical Characteristics

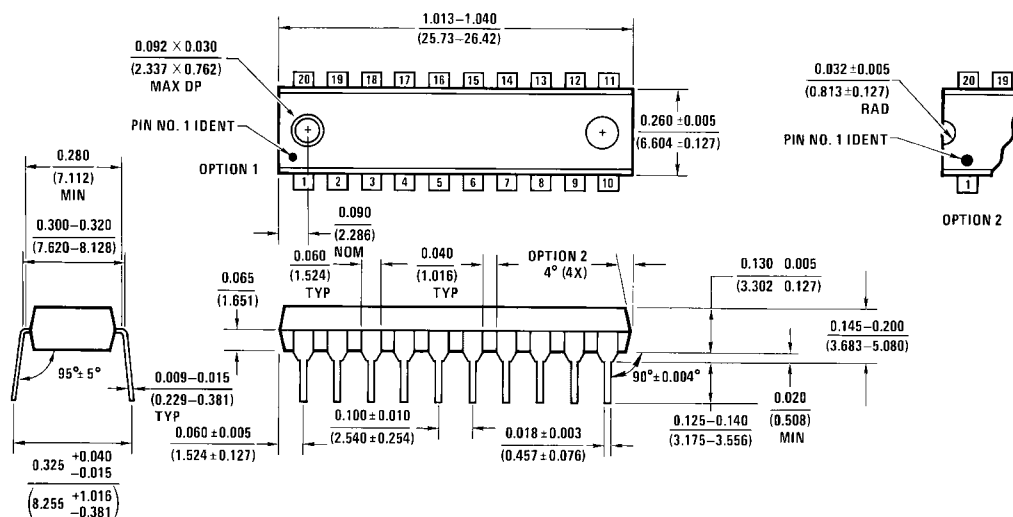
Symbol	Parameter	T _A = +25°C V _{CC} = +5.0V C _L = 50 pF			T _A = 0°C to +70°C V _{CC} = +5.0V C _L = 50 pF		Units
		Min	Typ	Max	Min	Max	
t _{PLH}	Propagation Delay	6.0	11.0	16.0	6.0	17.0	ns
t _{PHL}	A _n to O _n	4.0	7.5	11.0	4.0	12.0	
t _{PLH}	Propagation Delay	5.0	8.5	14.5	5.0	15.5	
t _{PHL}	$\overline{E}_1$ to O _n	4.0	6.5	9.0	4.0	10.0	
t _{PLH}	Propagation Delay	6.0	11.0	16.0	6.0	17.0	ns
t _{PHL}	E ₂ to O _n	5.0	10.0	14.0	5.0	15.0	
t _{PLH}	Propagation Delay	6.0	11.5	18.0	6.0	20.0	
t _{PHL}	P to O _n	6.0	11.0	16.0	6.0	17.0	
t _{PZH}	Output Enable Time	3.0	5.5	10.5	3.0	11.5	ns
t _{PZL}	$\overline{OE}$ to O _n	5.0	9.0	13.0	5.0	14.0	
t _{PHZ}	Output Disable Time	2.0	4.0	6.0	2.0	7.0	
t _{PLZ}	$\overline{OE}$ to O _n	3.0	5.0	7.0	3.0	8.0	

Physical Dimensions inches (millimeters) unless otherwise noted



20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
Package Number M20B

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide
Package Number N20A

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